Notice of References Cited

Application/Control No. 10/671,773	Applicant(s)/Patent Under Reexamination CHIU ET AL.		
Examiner	Art Unit		
Fernando L. Toledo	2823	Page 1 of 1	

U.S. PATENT DOCUMENTS

* .		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,627,403 A	05-1997	Bacchetta et al.	257/639
	В.	US-6,235,592 B1	05-2001	Sung, Kuan-Chou	438/278
	С	US-6,242,303 B1	06-2001	Wang et al.	438/257
	D	US-6,346,737 B1	02-2002	Higashitani et al.	257/511
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	Ţ,	US-		Mining Annual Control of the Control	
	J	US-	, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	
	К	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Wolf and Tauber; "Silicon Processing for the VLSI Era Volume 1: Process Technology"; pp. 161 and 168; 1986, Lattice Press; Sunset Beach, CA				
	>					
	W					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.